

(UNITS: mm)

Reliability Data Summary:			
QV DEVICE NAME:			
Hi-real test	Sample size(PC)	Condition	ACC/REJ
High Temperature Reverse Bias	77	Ta=150°C±5°C VR=480V. for 1000 Hrs.	ACC
Thermal Fatigue Testing	77	ON: 300 sec / Off: 300 sec for 1000 cycles	ACC
Solder resistance	77	260±5°C for 10±2 Sec.	ACC
Thermal Shock	77	55°C±5°C/5MIN AND 150±5°C/5MIN for 100 cycles	ACC
Electrical Characteristic Summary:		Electrical characteristics are not impacted	
List of Affected Parts:		Note: Only the standard (off the shelf) part numbers are listed in the parts list. Any custom parts affected by this EOL are shown in the customerspecific EOL addendum in the EOL email notification, or on the EOL Customized Portal.	
Part Number	New spec	Addition	Mark
TCMBD914	TCMBD914 202012-O	Including to House #	

V-AE19A1 Rev:C